

<b>Notice of References Cited</b>	Application/Control No. 10/664,834	Applicant(s)/Patent Under Reexamination FENG, CHEN	
	Examiner Seung H. Lee	Art Unit 2876	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,511,205	04-1996	Kannan et al.	713/324
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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